	Based on Form (3/90)	Based on Form PTO-1449 (3/90)				ATTY. DOCKET NO.		SERIAL NO. 10/621, 236		
	LIST OF DETERMINE CHARD DV					514413-3941 APPLICANT	To be assigned			
	LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)									
					Dr. Erwin HACKER, et al.					
				FILING DATE		GROUP (6)6				
						Herewith		To b	e assigned	
	ry a men	γ —	DOCUMENT NUMBER	T	U.S. PATI	J.S. PATENT DOCUMENTS		<u> </u>		
	EXAMINER INITIAL		DOCUMENT NUMBER	DATE	<u> </u>	NAME	CLASS	SUBCLASS		G DATE OPRIATE
	SIM	AA	US 4,249,937	02/10/81	Iwatal	ki et al.	ļ/	/		
لـ	SM	AB	US 4,422,864	12/27/83	Becke	Becker et al.				- <u></u> -
	Sin	AC	US 5,190,573	03/02/93	Missli	itz et al.				
1	M	AD	US 5,703,008	12/30/97	Rösch	et al.				
	ML	AE	US 6,124,240	09/26/00	Bierin	ger et al.				
	FOREIGN PATENT DOCUMENTS									
			DOCUMENT NUMBER	DATE		COUNTRY	CLASS	SUBCLASS	TRANS	LATION
ŀ	(20			<u> </u>	 		! 	1	YES	NO
↲	Vin	- AE	WO 99/57982	11/18/99	WIPC)				
	an	AF	WO 99/08520	02/25/99	WIPO					
	SMC	AG	EP 0 071 707 A1	02/16/83	EURC	EUROPE				
	M	AH -	EP 0 070 370 (and English equivalent U.S. Pat. No. 4,422,864 cited above)	01/26/83	EURC	EUROPE				
1	M	AI -	EP 0 456 112 A1 (and English equivalent U.S. Pat. No. 5,190,573 cited above)	11/13/91	EURC	PPE				
	SM	AJ	GB 2 090 246	07/07/82	GREA	T BRITAIN				
1	M	AK .	JP 52-95636 (No English equivalent available)	08/11/77	JAPA	N				
<u> </u>	me	AL.	JP 52-112945 (and English equivalent U.S. Pat. No. 4,249,937 cited above)	09/21/77	JAPA	N				
OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)										
L	AJ									
ŀ	AK AK									
ŀ	EXAMINER	AL				T				
		./0	Mark Co.	3		DATE CONSIDERED	100	<i></i>		
	 EXAMINER: citation if not in 	Initial if refer conformance	rence considered, whether or not considered. Include copy	itation is in conform	mance with	MPEP 609. Draw line through mication to applicant.				